

EAST Search History (12 pp.)

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|------|---|---|------------------|---------|------------------|
| L1 | 2 | ("5912842").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/06 07:20 |
| L2 | 149 | flash adj memory and (bbhe (hot adj electron) near4 band-to-band) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/06 07:49 |
| L5 | 2389 | ((257/321) or (365/185.19) or (365/185.28)).CCLS. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/06 07:49 |
| L6 | 42 | 5 and flash adj memory and (hot adj electron near4 band-to-band) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/06 07:53 |
| L7 | 46 | 5 and flash adj memory and (BBHE (hot adj electron near4 band-to-band)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/06 07:55 |
| L8 | 2 | ("6011725").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/06 07:57 |
| L10 | 1057 | band-to-band adj tunneling | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/06 07:58 |
| L11 | 3 | "6610567" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/06 08:01 |
| L12 | 2 | ("7078761").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/06 08:01 |
| L13 | 1 | "5736764".PN. | USPAT; USOCR | OR | OFF | 2006/08/06 08:05 |

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| S1 | 5 | "753673".ap. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/04 23:05 |
| S2 | 2 | ("5761121").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 07:16 |
| S3 | 2 | EP-776049\$-\$ did. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 07:19 |
| S4 | 2 | ("5912842").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 07:23 |
| S5 | 0 | ("two-transistor near3(PMOSPMOS FET)").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 07:24 |
| S6 | 2 | two-transistor near3 (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 07:29 |
| S7 | 574 | common adj (drain source "source/drain") and floating adj gate and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/02/22 07:30 |
| S8 | 115 | common adj (drain source "source/drain") and floating adj gate and (PMOS PMOSFET) and select adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/02/22 07:31 |
| S9 | 115 | common adj (drain source "source/drain") and floating adj gate and (PMOS PMOSFET) and select adj gate and memory | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/02/22 07:54 |
| S10 | 10 | implant near6 common near2 (drain source "source/drain") and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/02/22 07:55 |

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| S11 | 10 | (halo implant) near6 common near2 (drain source "source/drain") and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/02/22 07:55 |
| S12 | 2 | (US-6207991-\$ or US-5877051-\$). did. | USPAT | OR | OFF | 2005/02/22 08:04 |
| S13 | 12 | (US-20050030827-\$ or US-20030034510-\$).did. or (US-5761121-\$ or US-5912842-\$ or US-5943265-\$ or US-5687118-\$ or US-6207991-\$ or US-5877051-\$ or US-6146936-\$).did. or (EP-776049-\$ or WO-9919880-\$). did. or (EP-776049-\$).did. | US-PGPUB; USPAT; EPO; DERWENT | OR | OFF | 2005/02/22 08:08 |
| S14 | 215 | two adj transistor near4 memory adj cell | US-PGPUB; USPAT; EPO; DERWENT | OR | OFF | 2005/02/22 08:08 |
| S15 | 99 | two adj transistor near4 memory adj cell and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; DERWENT | OR | ON | 2005/02/22 08:09 |
| S16 | 99 | two adj transistor near4 memory adj cell and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:13 |
| S17 | 249 | implant and (punch-through punch adj "through") and common adj (source drain "source/drain") | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:15 |
| S18 | 190 | implant and (punch-through punch adj "through") and common adj (source drain "source/drain") and memory | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:15 |
| S19 | 39 | implant and (punch-through punch adj "through") and common adj (source drain "source/drain") and memory and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:22 |
| S20 | 39 | (halo implant) and (punch-through punch adj "through") and common adj (source drain "source/drain") and memory and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:24 |
| S21 | 0 | halo near6 punch-through and halo near6 common near2 (source-drain source/drain drain) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:25 |

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| S22 | 6 | halo near6 (punchthrough punch adj through punch-through) and common near2 (source-drain source/drain drain) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:42 |
| S23 | 7 | chang.in. and S13 | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 08:52 |
| S24 | 2 | S23 and polysilicon and (bit adj line bitline bit adj line) and floating adj gate and select adj gate and (tunneling tunnelling) near3 (Fowler Nordheim) and (thick thickness) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 09:39 |
| S25 | 1 | S23 and polysilicon and (bit adj line bitline bit adj line) and control adj gate near6 polysilicon | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 09:52 |
| S26 | 0 | S23 and polysilicon and floating adj gate and control adj gate near6 (body adj bias back-gate back adj gate) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 09:53 |
| S27 | 49 | control adj gate near6 (body adj bias back-gate back adj gate) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 09:54 |
| S28 | 26 | control adj gate near6 (body adj bias back-gate back adj gate) and floating adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 09:55 |
| S29 | 7 | control adj gate near6 (body adj bias back-gate back adj gate) and floating adj gate and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | ON | 2005/02/22 09:56 |
| S30 | 12 | (US-20050030827-\$ or US-20030034510-\$).did. or (US-5761121-\$ or US-5912842-\$ or US-5943265-\$ or US-5687118-\$ or US-6207991-\$ or US-5877051-\$ or US-6146936-\$).did. or (EP-776049-\$ or WO-9919880-\$).did. or (EP-776049-\$).did. | US-PGPUB; USPAT; EPO; DERWENT | OR | OFF | 2005/02/22 10:27 |
| S31 | 0 | S30 and (thick thickness) near4 (drain source) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 10:28 |

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|-----|------|--|---|----|-----|------------------|
| S32 | 1 | S30 and (depth thick thickness) near4 (drain source) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 10:30 |
| S33 | 33 | (depth thick thickness) near4 (drain source) and floating adj gate and halo | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 10:50 |
| S34 | 278 | "100" near2 kev near10 phosphorus same implantation and (depth thickness thick) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 10:52 |
| S35 | 12 | "100" near2 kev near10 phosphorus near10 (depth thickness) same implantation and (depth thickness thick) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 11:09 |
| S36 | 5789 | ((257/213) or (257/239) or (257/288) or (257/261) or (257/314) or (257/315) or (257/e21.179) or (257/e21.422) or (257/e21.68)).CCLS. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 11:10 |
| S37 | 15 | S36 and (halo implant) and floating adj gate and punch adj through and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 11:12 |
| S38 | 1151 | (365/185\$2).CCLS. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 11:12 |
| S39 | 5 | S38 and (halo implant) and floating adj gate and punch adj through and (PMOS PMOSFET) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/02/22 11:12 |
| S40 | 718 | halo adj implant | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 12:09 |
| S41 | 48 | halo adj implant and floating adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 12:20 |

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|-----|------|--|---|----|-----|------------------|
| S42 | 310 | (counter-doped halo) and floating adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 12:21 |
| S43 | 383 | (counter adj dop\$3 halo) and floating adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 12:21 |
| S44 | 398 | (counter adj dop\$3 halo) and floating adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 12:47 |
| S45 | 0 | floating adj gate near20 (logic\$2 address select) adj gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 12:47 |
| S46 | 1149 | floating adj gate near20 ((logic\$2 address select) adj gate) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 12:48 |
| S47 | 0 | floating adj gate near20 ((logic\$2 address select) adj gate) and halo near4 "only" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 12:48 |
| S48 | 0 | floating adj gate near20 ((logic\$2 address select) adj gate) and halo near4 ("exclusively" "only") | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 12:48 |
| S49 | 0 | floating adj gate near20 ((logic\$2 address select) adj gate) and halo near4 ("exclusively" "only" "one" adj side) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 12:49 |
| S50 | 27 | floating adj gate near20 ((logic\$2 address select) adj gate) and halo | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 13:09 |
| S51 | 184 | floating adj gate near20 ((logic\$2 address select) adj gate) and buried | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 13:40 |

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| S52 | 0 | floating adj gate near20 ((logic\$2 address select) adj gate) and counter adj doping | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 13:40 |
| S53 | 203 | floating adj gate near20 ((logic\$2 address select) adj gate) and (counter adj dop\$3 buried halo) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:04 |
| S54 | 7 | punch adj "through" near6 (oxynitride ONO roxnox) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:08 |
| S55 | 2 | ("6180443").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 14:08 |
| S56 | 2 | S55 and implant\$5 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 14:10 |
| S57 | 304 | floating near1 gate and (select logic\$2 address) near1 gate and punch adj through | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:13 |
| S58 | 1062 | floating near1 gate and (control select logic\$2 address) near1 gate and punch adj through | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:14 |
| S59 | 1802 | floating near1 gate and (control select logic\$2 address) near1 gate and (over adj erase punch adj through) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:14 |
| S60 | 1802 | floating near1 gate and (control select logic\$2 address) near1 gate and ("over" adj erase punch adj through) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:14 |
| S61 | 500 | floating near1 gate and (control select logic\$2 address) near1 gate and ("over" adj erase punch adj through) and (buried counter adj dop\$3 halo) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 14:17 |

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| S62 | 2 | ("5912842").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 16:42 |
| S63 | 9458 | ((257/213) or (257/239) or (257/288) or (257/261) or (257/314) or (257/315) or (257/e21.179) or (257/e21.422) or (365/185.12) or (365/185.13) or (365/185.17) or (365/185.18) or (365/185.29)).CCLS | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/10/17 16:43 |
| S64 | 29 | S63 and floating and (halo counter adj dop\$3 buried) near10 (punch adj "through") | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/10/17 16:44 |
| S65 | 2 | ("5912842").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/04 23:07 |
| S66 | 2 | "20040070030".pn. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/04 23:16 |
| S67 | 10043 | ((257/213) or (257/239) or (257/288) or (257/261) or (257/314) or (257/315) or (257/e21.179) or (257/e21.422) or (257/e21.68) or (365/185.12) or (365/185.13) or (365/185.17) or (365/185.18)).CCLS | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/04 23:17 |
| S68 | 23 | S67 and ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and (implant buried) and common adj ("source/drain" "S/D" source-drain (source adj drain)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:25 |
| S69 | 24 | S67 and ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and (implant buried halo) and common adj ("source/drain" "S/D" source-drain (source adj drain)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:27 |

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| S70 | 27 | S67 and ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and (implant buried halo) and common adj ("source/drain" "S/D" source-drain (source near2 drain)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:28 |
| S71 | 63 | S67 and ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and common adj ("source/drain" "S/D" source-drain (source near2 drain)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:31 |
| S72 | 342 | ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and common adj ("source/drain" "S/D" source-drain (source near2 drain)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:32 |
| S73 | 276 | ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and common adj ("source/drain" "S/D" source-drain (source near2 drain)) and @ad<"20040108" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:34 |
| S74 | 151 | ("low" "lower" decrease decreasing improvement improve improving) near4 threshold and common adj ("source/drain" "S/D" source-drain (source near2 drain)) and @ad<"20040108" and memory and floating | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:49 |
| S75 | 559 | common adj ("source/drain" "S/D" source-drain (source near2 drain)) and @ad<"20040108" and memory and floating | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/04 23:58 |
| S76 | 1 | common adj ("source/drain" "S/D" source-drain (source near2 drain)) with pocket and @ad<"20040108" and memory and floating | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 00:05 |
| S77 | 1 | "5751631".PN. | USPAT; USOCR | OR | OFF | 2006/08/04 23:59 |
| S78 | 1 | "6074914".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:00 |
| S79 | 1 | "6074915".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:01 |
| S80 | 1 | "6103602".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:03 |
| S81 | 1 | "6103602".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:04 |

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| S82 | 1 | common adj ("source/drain" "S/D" source-drain (source near2 drain)) same pocket and @ad<"20040108" and memory and floating | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 00:07 |
| S83 | 2 | ("5761121").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 00:24 |
| S84 | 1 | "4404577".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:09 |
| S85 | 1 | "4425631".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:10 |
| S86 | 1 | "4630087".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:10 |
| S87 | 1 | "5089433".PN. | USPAT; USOCR | OR | OFF | 2006/08/05 00:10 |
| S88 | 0 | buried with (counter-doped counter-doping oppositely) with (common adj (source near1 drain)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 00:25 |
| S89 | 21 | buried with (common adj (source near1 drain)) and floating and gate | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 00:49 |
| S90 | 126 | (punch adj through punch-through) and common adj (source-drain source adj drain) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 01:13 |
| S91 | 126 | (punch adj through punch-through) and common adj (source-drain source adj drain "S/D") | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 01:13 |
| S92 | 5356 | ((p-type pmos pmosfet) near4 (memory floating adj gate)) "5912842".pn. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 10:24 |
| S93 | 1111 | ((p-type pmos pmosfet) near4 (memory floating adj gate)) and common near1 (drain source)) "5912842".pn. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 10:25 |

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| S94 | 197 | ((p-type pmos pmosfet) near4 (memory floating adj gate) and common near1 (drain source) and (implant pocket)) "5912842".pn. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 11:17 |
| S95 | 9 | ((p-type pmos pmosfet) near4 (memory floating adj gate) and common near1 (drain source) and halo) "5912842".pn. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 11:21 |
| S96 | 9 | floating adj gate and select adj gate and (pocket implant) near10 (threhold adj voltage resistance resistivity) and (p-type adj channel p-type adj drain p-type source pmosfet pmos) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 11:39 |
| S97 | 11 | ("6861700") or ("7018895") or ("5284784") or ("6818512") or ("5824584").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 11:39 |
| S98 | 3 | ("6909139").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 18:34 |
| S99 | 420 | (PMOS PMOSFET) and floating adj gate and select adj gate and threshold adj voltage | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 18:36 |
| S100 | 139 | (PMOS PMOSFET) and floating adj gate and select adj gate and threshold adj voltage and (implant pocket) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 18:44 |
| S101 | 19 | (PMOS PMOSFET) and floating adj gate and select adj gate and threshold adj voltage and (implant pocket) and common near1 (drain source) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 18:53 |
| S102 | 1 | (PMOS PMOSFET) and floating adj gate and select adj gate and (implant pocket) near20 common near1 (drain source) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 18:56 |

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|----------|------|---|---|----|-----|------------------|
| S10 3 | 21 | floating adj gate and select adj gate and (implant pocket) near20 common near1 (drain source) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 18:56 |
| S10 4 | 2456 | 257/315.ccls. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 21:34 |
| S10 5 | 2001 | 257/315.ccls. and @pd>"19960401" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 21:34 |
| S10 6 | 459 | 257/315.ccls. and @pd<"19960501" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/08/05 21:51 |
| S10 7 | 1521 | 257/316.ccls. not 257/315.ccls. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/08/05 21:51 |